

NPIC6C596A-Q100

Power logic 8-bit shift register; open-drain outputs

Rev. 1 — 18 October 2013

Product data sheet

1. General description

The NPIC6C596A-Q100 is an 8-bit serial-in/serial or parallel-out shift register with a storage register and open-drain outputs. Both the shift and storage register have separate clocks. The device features a serial input (DS) and a serial output (Q7S) to enable cascading and an asynchronous reset \overline{MR} input. A LOW on \overline{MR} resets both the shift register and storage register. Data is shifted on the LOW-to-HIGH transitions of the SHCP input. The data in the shift register is transferred to the storage register on a LOW-to-HIGH transition of the STCP input. If both clocks are connected together, the shift register is always one clock pulse ahead of the storage register. To provide additional hold time in cascaded applications, the serial output QS7 is clocked out on the falling edge of SHCP. Data in the storage register drives the gate of the output extended-drain NMOS (EDNMOS) transistor whenever the output enable input (\overline{OE}) is LOW. A HIGH on \overline{OE} causes the outputs to assume a high-impedance OFF-state. Operation of the \overline{OE} input does not affect the state of the registers. The open-drain outputs are 33 V/100 mA continuous current extended-drain NMOS transistors designed for use in systems that require moderate load power such as LEDs. Integrated voltage clamps in the outputs, provide protection against inductive transients. These voltage clamps make the device suitable for power driver applications such as relays, solenoids and other low-current or medium-voltage loads.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
 - ◆ Specified from $-40\text{ }^{\circ}\text{C}$ to $+85\text{ }^{\circ}\text{C}$ and from $-40\text{ }^{\circ}\text{C}$ to $+125\text{ }^{\circ}\text{C}$
- Wide supply range 2.3 V to 5.5 V
- Low R_{DSon}
- Eight Power EDNMOS transistor outputs of 100 mA continuous current
- 250 mA current limit capability
- Output clamping voltage 33 V
- 30 mJ avalanche energy capability
- Enhanced cascading for multiple stages
- All registers cleared with single input
- Low power consumption
- ESD protection:
 - ◆ HBM AEC-Q100-002 revision D exceeds 2500 V
 - ◆ CDM AEC-Q100-011 revision B exceeds 1000 V

3. Applications

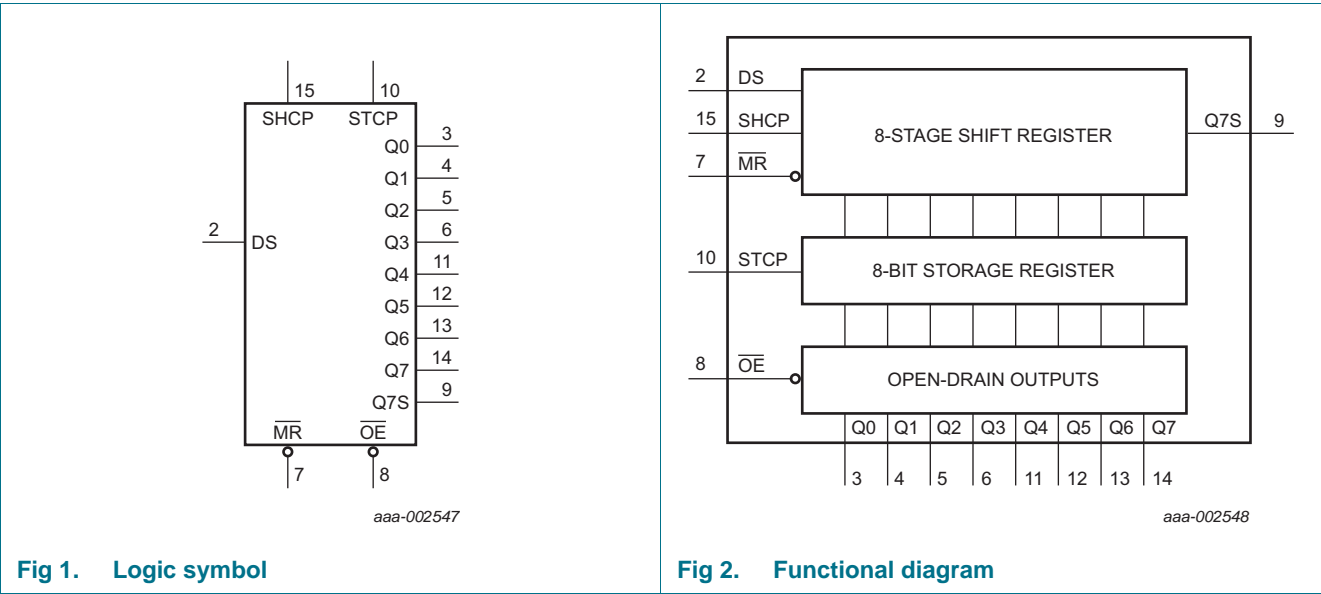
- LED sign
- Graphic status panel
- Fault status indicator

4. Ordering information

Table 1. Ordering information

| Type number | Package | | | |
|-------------------|-------------------|----------|--|----------|
| | Temperature range | Name | Description | Version |
| NPIC6C596AD-Q100 | −40 °C to +125 °C | SO16 | plastic small outline package; 16 leads; body width 3.9 mm | SOT109-1 |
| NPIC6C596APW-Q100 | −40 °C to +125 °C | TSSOP16 | plastic thin shrink small outline package; 16 leads; body width 4.4 mm | SOT403-1 |
| NPIC6C596ABQ-Q100 | −40 °C to +125 °C | DHVQFN16 | plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 × 3.5 × 0.85 mm | SOT763-1 |

5. Functional diagram



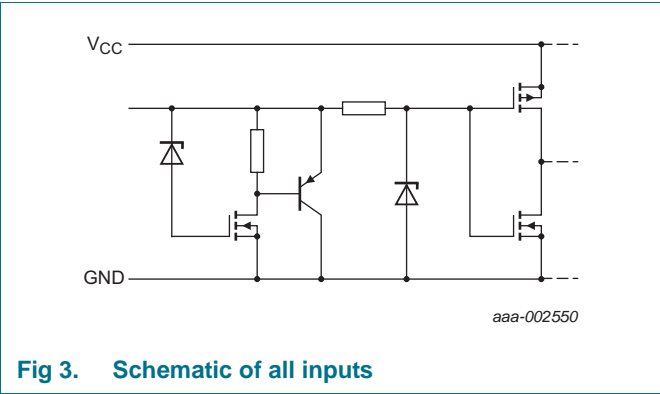


Fig 3. Schematic of all inputs

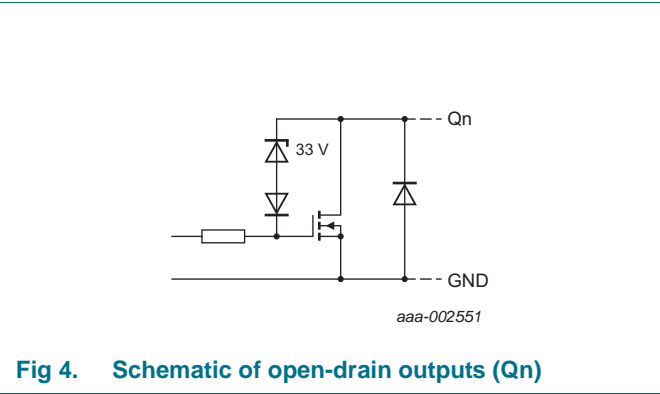


Fig 4. Schematic of open-drain outputs (Qn)

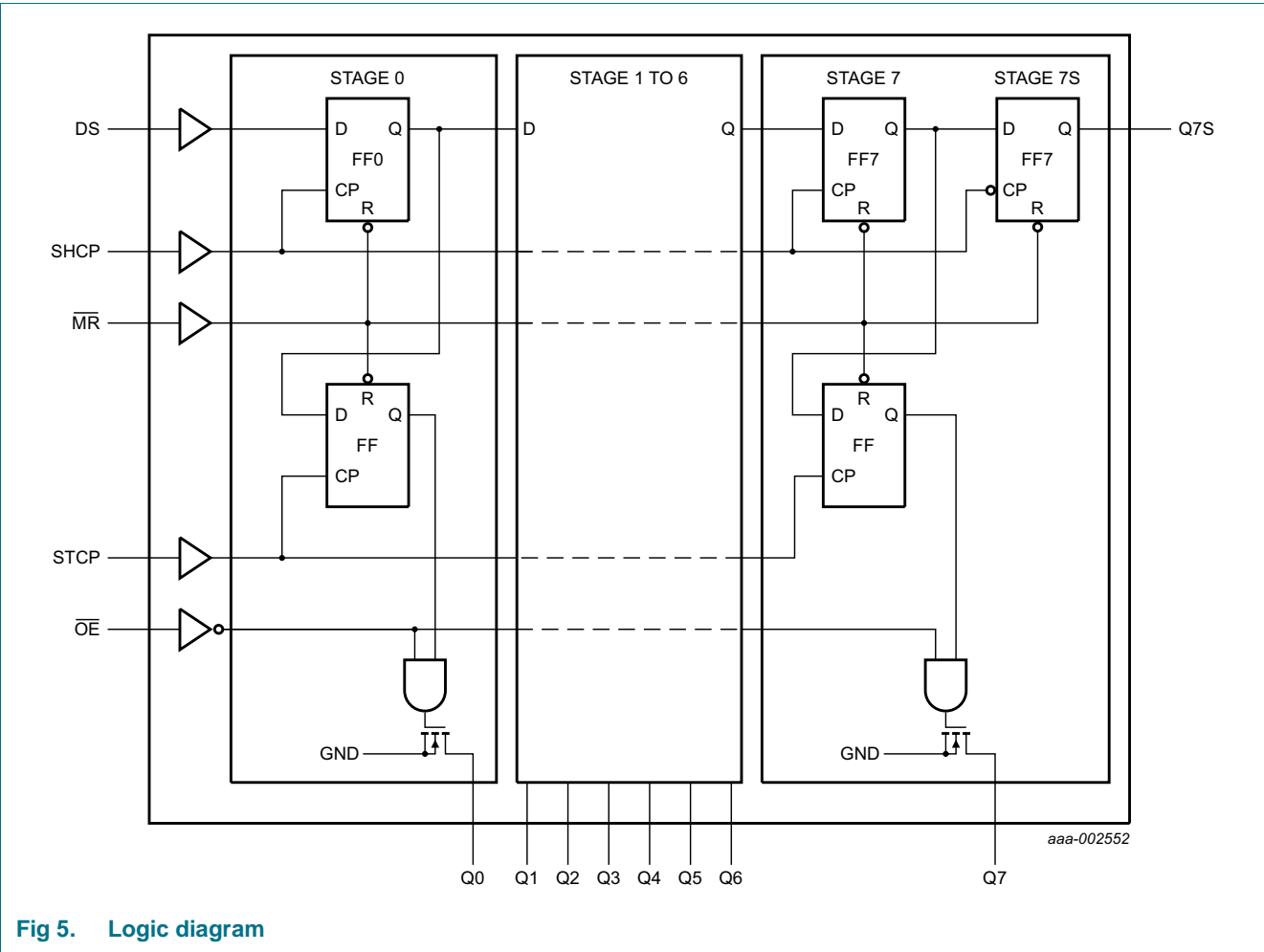


Fig 5. Logic diagram

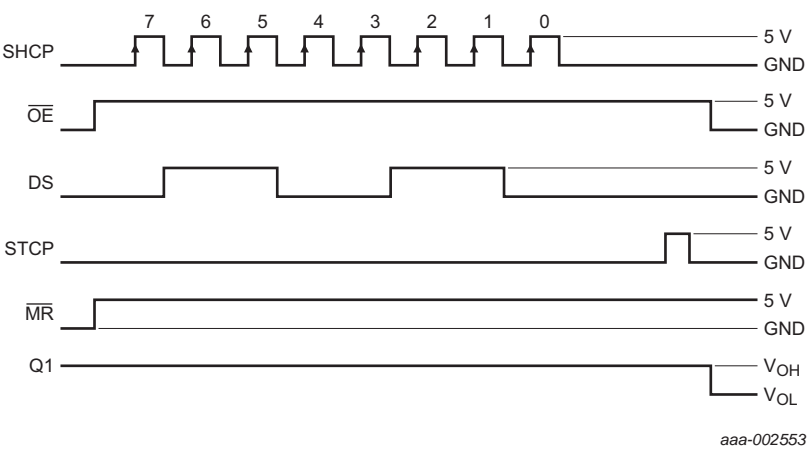


Fig 6. Timing diagram

6. Pinning information

6.1 Pinning

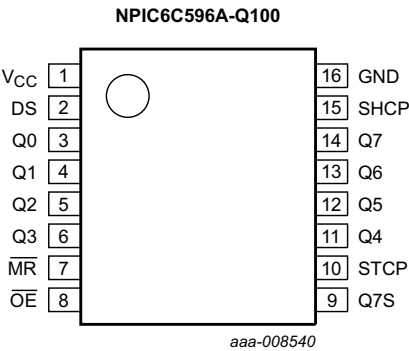
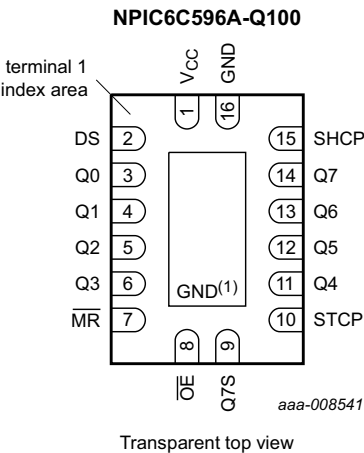


Fig 7. Pin configuration SO16 and TSSOP16



- (1) This is not a supply pin. The substrate is attached to this pad using conductive die attach material. There is no electrical or mechanical requirement to solder this pad. However, if it is soldered, the solder land should remain floating or be connected to GND.

Fig 8. Pin configuration DHVQFN16

6.2 Pin description

Table 2. Pin description

| Symbol | Pin | Description |
|--------------------------------|----------------------------|-----------------------------------|
| V _{CC} | 1 | supply voltage |
| DS | 2 | serial data input |
| Q0, Q1, Q2, Q3, Q4, Q5, Q6, Q7 | 3, 4, 5, 6, 11, 12, 13, 14 | parallel data output (open-drain) |
| $\overline{\text{MR}}$ | 7 | master reset (active LOW) |
| $\overline{\text{OE}}$ | 8 | output enable input (active LOW) |
| Q7S | 9 | serial data output |
| STCP | 10 | storage register clock input |
| SHCP | 15 | shift register clock input |
| GND | 16 | ground (0 V) |

7. Limiting values

Table 3. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|--------------------|---------------------------------|--|------|------|------|
| V _{CC} | supply voltage | | −0.5 | +7.0 | V |
| V _I | input voltage | | −0.3 | +7.0 | V |
| V _{DS} | drain-source voltage | power EDNMOS drain-source voltage [1] | - | +33 | V |
| I _{d(SD)} | source-drain diode current | continuous | - | 250 | mA |
| | | pulsed [2] | - | 500 | mA |
| I _D | drain current | T _{amb} = 25 °C | | | |
| | | continuous; each output; all outputs on | - | 100 | mA |
| | | pulsed; each output; all outputs on [2] | - | 250 | mA |
| I _{DM} | peak drain current | single output; T _{amb} = 25 °C [2] | - | 250 | mA |
| E _{AS} | non-repetitive avalanche energy | single pulse; see Figure 9 [3] | - | 30 | mJ |
| I _{AL} | avalanche current | see Figure 9 [3] | - | 200 | mA |
| T _{stg} | storage temperature | | −65 | +150 | °C |

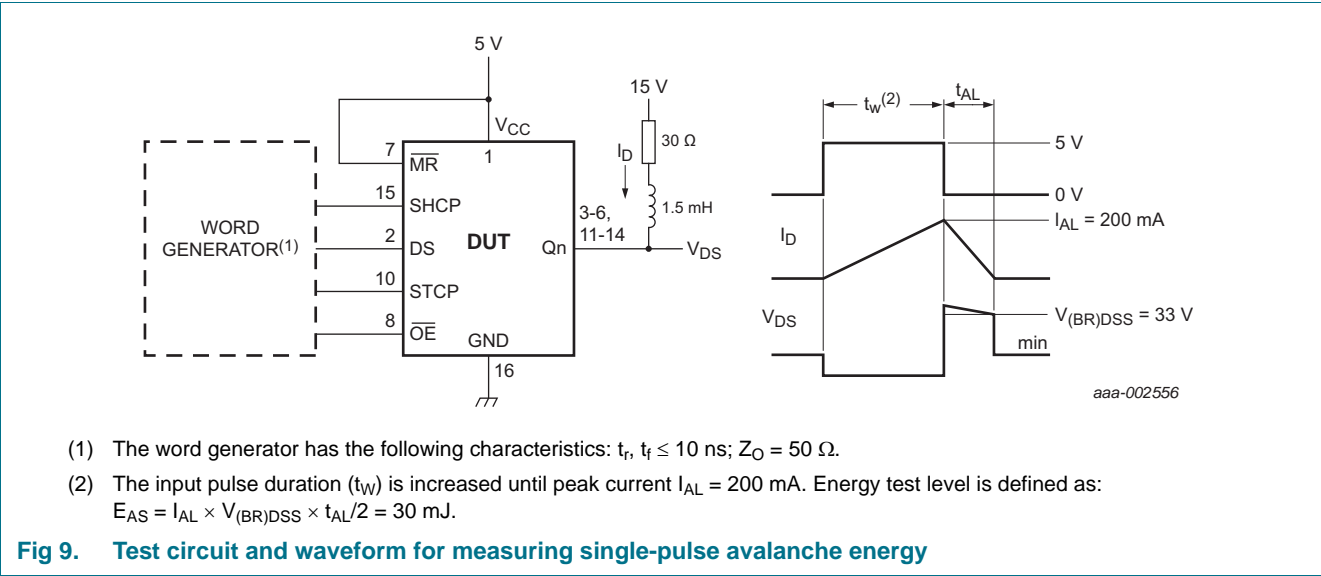
Table 3. Limiting values ...continued

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|------------------|-------------------------|--|-----|------|------|
| P_{tot} | total power dissipation | $T_{\text{amb}} = 25\text{ }^{\circ}\text{C}$ | [4] | | |
| | | SO16 | - | 800 | mW |
| | | TSSOP16 | - | 725 | mW |
| | | DHVQFN16 | - | 1825 | mW |
| | | $T_{\text{amb}} = 125\text{ }^{\circ}\text{C}$ | [4] | | |
| | | SO16 | - | 160 | mW |
| | | TSSOP16 | - | 145 | mW |
| | | DHVQFN16 | - | 365 | mW |

- [1] Each power EDNMOS source is internally connected to GND.
- [2] Pulse duration $\leq 100\text{ }\mu\text{s}$ and duty cycle $\leq 2\text{ }\%$.
- [3] $V_{\text{DS}} = 15\text{ V}$; starting junction temperature (T_j) = $25\text{ }^{\circ}\text{C}$; $L = 1.5\text{ H}$; avalanche current (I_{AL}) = 200 mA .
- [4] For SO16 packages: above $25\text{ }^{\circ}\text{C}$ the value of P_{tot} derates linearly with $6.4\text{ mW}/^{\circ}\text{C}$.
For TSSOP16 packages: above $25\text{ }^{\circ}\text{C}$ the value of P_{tot} derates linearly with $5.8\text{ mW}/^{\circ}\text{C}$.
For DHVQFN16 packages: above $25\text{ }^{\circ}\text{C}$ the value of P_{tot} derates linearly with $14.6\text{ mW}/^{\circ}\text{C}$.

7.1 Test circuit and waveform



8. Recommended operating conditions

Table 4. Recommended operating conditions

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|-----------|---------------------|--|--------|-----|------|------|
| V_{CC} | supply voltage | | 2.3 | - | 5.5 | V |
| V_I | input voltage | | 0 | - | 5.5 | V |
| I_D | drain current | pulsed drain output current; $V_{CC} = 5\text{ V}$; $T_{amb} = 25\text{ °C}$; all outputs on | [1][2] | - | 250 | mA |
| T_{amb} | ambient temperature | | -40 | - | +125 | °C |

[1] Pulse duration $\leq 100\text{ }\mu\text{s}$ and duty cycle $\leq 2\%$.

[2] Technique should limit $T_j - T_{amb}$ to 10 °C maximum.

9. Static characteristics

Table 5. Static characteristics

At recommended operating conditions unless otherwise specified. Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | $T_{amb} = 25\text{ °C}$ | | | Unit |
|---------------|--------------------------------|--|--------------------------|--------|--------------|---------------|
| | | | Min | Typ[1] | Max | |
| V_{IH} | HIGH-level input voltage | $V_{CC} = 3.0\text{ V}$ to 5.5 V | $0.85V_{CC}$ | - | - | V |
| V_{IL} | LOW-level input voltage | $V_{CC} = 3.0\text{ V}$ to 5.5 V | - | - | $0.15V_{CC}$ | V |
| V_{OH} | HIGH-level output voltage | serial data output Q7S; $V_I = V_{IH}$ or V_{IL} | | | | |
| | | $I_O = -20\text{ }\mu\text{A}$; $V_{CC} = 3.0\text{ V}$ | 2.64 | 4.49 | - | V |
| | | $I_O = -4\text{ mA}$; $V_{CC} = 3.0\text{ V}$ | 2.4 | 4.2 | - | V |
| V_{OL} | LOW-level output voltage | serial data output Q7S; $V_I = V_{IH}$ or V_{IL} | | | | |
| | | $I_O = 20\text{ }\mu\text{A}$; $V_{CC} = 3.0\text{ V}$ | - | 0.005 | 0.12 | V |
| | | $I_O = 4\text{ mA}$; $V_{CC} = 3.0\text{ V}$ | - | 0.3 | 0.6 | V |
| I_I | input leakage current | $V_{CC} = 5.5\text{ V}$; $V_I = V_{CC}$ | - | - | 1 | μA |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 1\text{ mA}$ | 33 | 37 | - | V |
| V_{SD} | source-drain voltage | diode forward voltage; $I_F = 100\text{ mA}$ | - | 0.85 | 1.2 | V |
| I_{CC} | supply current | logic supply current; $V_{CC} = 5.5\text{ V}$; $V_I = V_{CC}$ or GND | | | | |
| | | all outputs off | - | 0.004 | 200 | μA |
| | | all outputs on [2] | - | 0.006 | 500 | μA |
| | | all outputs off; SHCP = 5 MHz; $C_L = 30\text{ pF}$; see Figure 14 and Figure 16 | - | 0.75 | 5 | mA |
| $I_{O(nom)}$ | nominal output current | $V_{DS} = 0.5\text{ V}$; $T_{amb} = 85\text{ °C}$; $I_{out} = I_D$ [3][4][5] | - | 140 | - | mA |
| I_{DSX} | drain cut-off current | $V_{CC} = 5.5\text{ V}$; $V_{DS} = 30\text{ V}$ | - | 0.002 | 0.2 | μA |
| | | $V_{CC} = 5.5\text{ V}$; $V_{DS} = 30\text{ V}$; $T_{amb} = 125\text{ °C}$ | - | 0.15 | 0.3 | μA |

Table 5. Static characteristics ...continued

At recommended operating conditions unless otherwise specified. Voltages are referenced to GND (ground = 0 V).

| Symbol | Parameter | Conditions | T _{amb} = 25 °C | | | Unit |
|-------------------|----------------------------------|---|--------------------------|--------------------|-----|------|
| | | | Min | Typ ^[1] | Max | |
| R _{DSon} | drain-source on-state resistance | see Figure 17 and Figure 18 ^{[3][4]} | | | | |
| | | V _{CC} = 3.0 V; I _D = 50 mA | - | 3.0 | 11 | Ω |
| | | V _{CC} = 3.0 V; I _D = 50 mA; T _{amb} = 125 °C | | 5.4 | 14 | Ω |
| | | V _{CC} = 3.0 V; I _D = 100 mA | - | 3.1 | 12 | Ω |

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 5.0 V.

[2] Output currents below 250 mA current limit.

[3] Technique should limit T_j – T_{amb} to 10 °C maximum.

[4] These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

[5] Nominal output current is defined for a consistent comparison between devices from different sources. It is the current that produces a voltage drop of 0.5 V at T_{amb} = 85 °C.

10. Dynamic characteristics

Table 6. Dynamic characteristicsVoltages are referenced to GND (ground = 0 V); For test circuit, see [Figure 14](#).

| Symbol | Parameter | Conditions | T _{amb} = 25 °C | | | Unit |
|------------------|------------------------------------|--|--------------------------|--------------------|-----|------|
| | | | Min | Typ ^[1] | Max | |
| t _{PLH} | LOW to HIGH propagation delay | $\overline{\text{OE}}$ to Q _n ; I _D = 75 mA; see Figure 10 and Figure 19 | - | 97 | - | ns |
| t _{PHL} | HIGH to LOW propagation delay | $\overline{\text{OE}}$ to Q _n ; I _D = 75 mA; see Figure 10 and Figure 19 | - | 9 | - | ns |
| t _r | rise time | $\overline{\text{OE}}$ to Q _n ; I _D = 75 mA; see Figure 10 and Figure 19 | - | 60 | - | ns |
| t _f | fall time | $\overline{\text{OE}}$ to Q _n ; I _D = 75 mA; see Figure 10 and Figure 19 | - | 18 | - | ns |
| t _{pd} | propagation delay | SHCP to Q7S; I _D = 75 mA; see Figure 11 ^[2] | - | 5 | - | ns |
| f _{max} | maximum frequency | SHCP; I _D = 75 mA; see Figure 11 ^[3] | - | - | 10 | MHz |
| t _{rr} | reverse recovery time | I _F = 100 mA; dI/dt = 10 A/μs; see Figure 13 ^{[4][5]} | - | 120 | - | ns |
| t _a | reverse recovery current rise time | I _F = 100 mA; dI/dt = 10 A/μs; see Figure 13 ^{[4][5]} | - | 100 | - | ns |
| t _{su} | set-up time | DS to SHCP; see Figure 12 | 15 | - | - | ns |
| t _h | hold time | DS to SHCP; see Figure 12 | 15 | - | - | ns |
| t _W | pulse width | | 40 | - | - | ns |

[1] Typical values are measured at T_{amb} = 25 °C and V_{CC} = 5.0 V.[2] t_{pd} is the same as t_{PLH} and t_{PHL}.

[3] This is the maximum serial clock frequency assuming cascaded operation where serial data is passed from one stage to a second stage. The clock period allows for SHCP → Q7S propagation delay and setup time plus some timing margin.

[4] Technique should limit T_j – T_{amb} to 10 °C maximum.

[5] These parameters are measured with voltage-sensing contacts separate from the current-carrying contacts.

10.1 Test circuits and waveforms

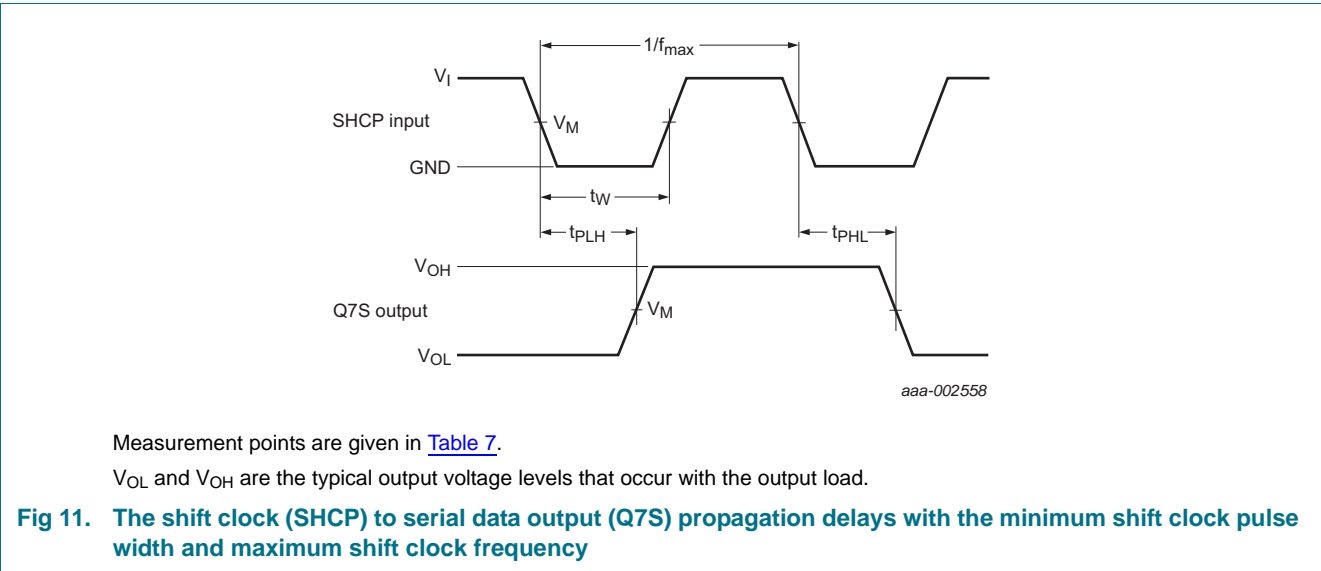
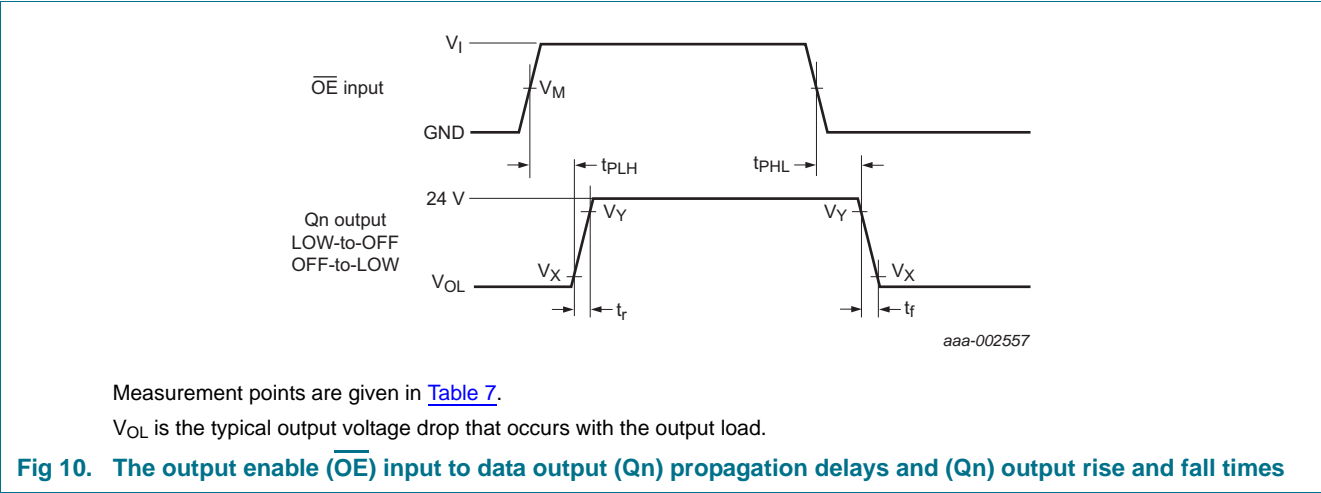
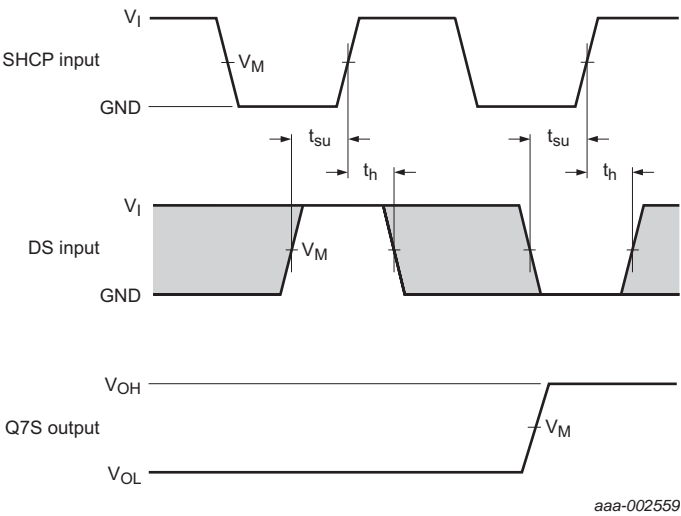


Table 7. Measurement points

| Supply voltage | Input | Output | | |
|----------------|-------------|-------------|-------------|-------------|
| V_{CC} | V_M | V_M | V_X | V_Y |
| 5 V | $0.5V_{CC}$ | $0.5V_{DS}$ | $0.1V_{DS}$ | $0.9V_{DS}$ |

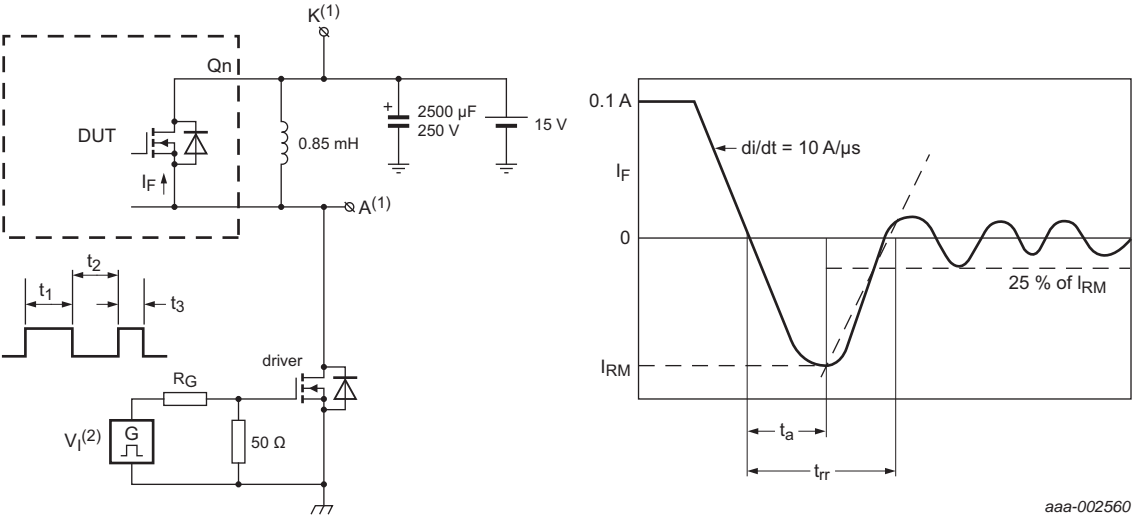


Measurement points are given in [Table 8](#).
The shaded areas indicate when the input is permitted to change for predictable output performance.
 V_{OL} and V_{OH} are the typical output voltage levels that occur with the output load.

Fig 12. The data set-up and hold times for the serial data input (DS)

Table 8. Measurement points

| Supply voltage | Input | Output |
|----------------|-------------|-------------|
| V_{CC} | V_M | V_M |
| 5 V | $0.5V_{CC}$ | $0.5V_{CC}$ |



- (1) The open-drain Qn terminal under test is connected to testpoint K. All other terminals are connected together and connected to testpoint A.
- (2) The V_I amplitude and R_G are adjusted for $di/dt = 10 \text{ A}/\mu\text{s}$. A V_I double-pulse train is used to set $I_F = 0.1 \text{ A}$, where $t_1 = 10 \mu\text{s}$, $t_2 = 7 \mu\text{s}$ and $t_3 = 3 \mu\text{s}$.

Fig 13. Test circuit and waveform for measuring reverse recovery current

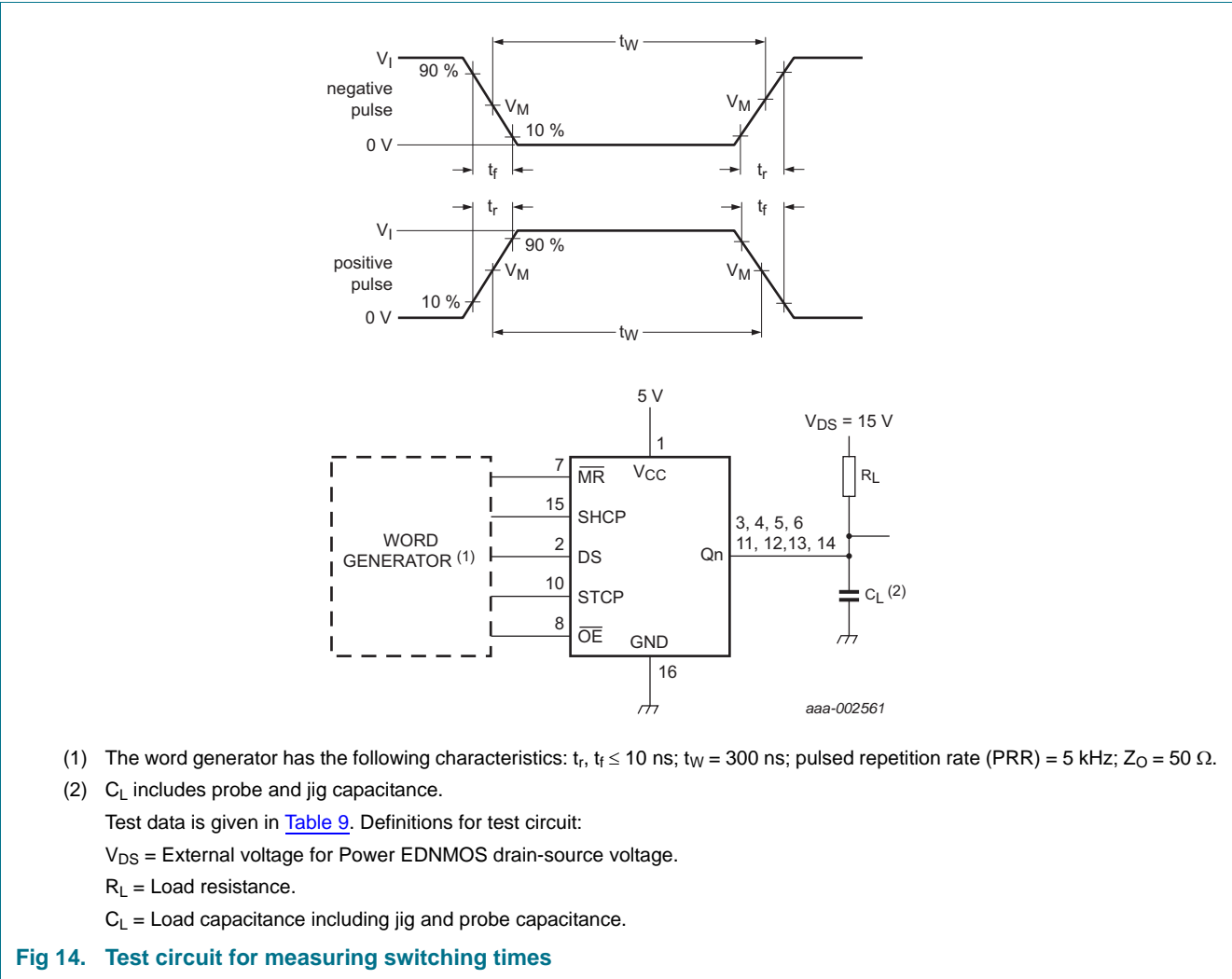
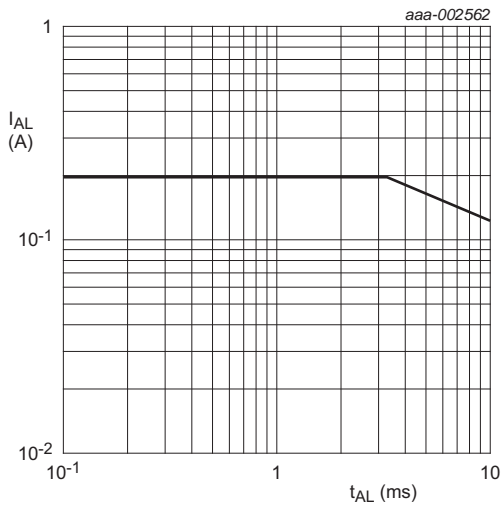


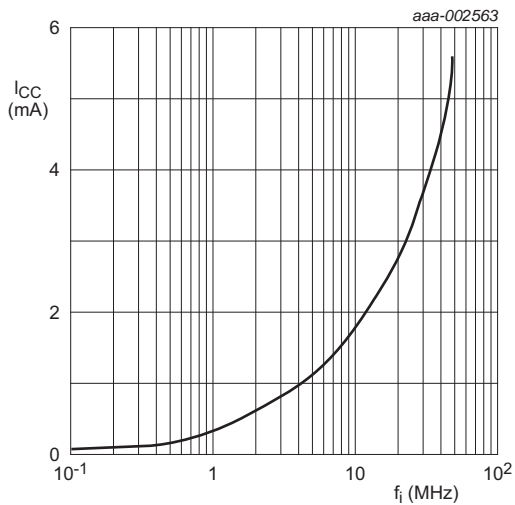
Table 9. Test data

| Supply voltage | Input | | | Load | |
|----------------|-------|----------------------|-------|-------|--------------|
| | V_I | t_r, t_f | V_M | C_L | R_L |
| 5 V | 5 V | $\leq 10 \text{ ns}$ | 50% | 30 pF | 200 Ω |



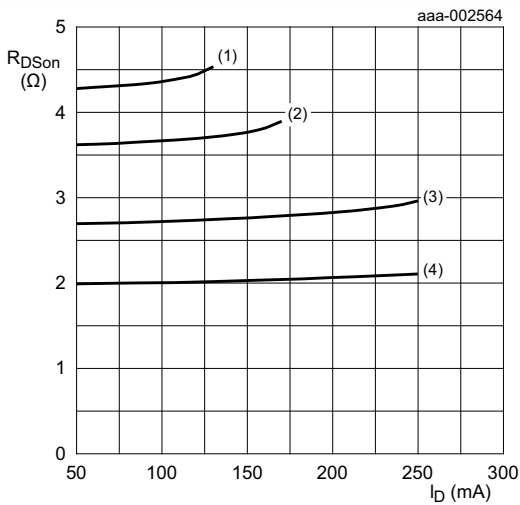
$T_{amb} = 25\text{ }^{\circ}\text{C}$.

Fig 15. Avalanche current (peak) versus time duration of avalanche



$T_{amb} = -40\text{ }^{\circ}\text{C}$ to $125\text{ }^{\circ}\text{C}$; $V_{CC} = 5\text{ V}$.

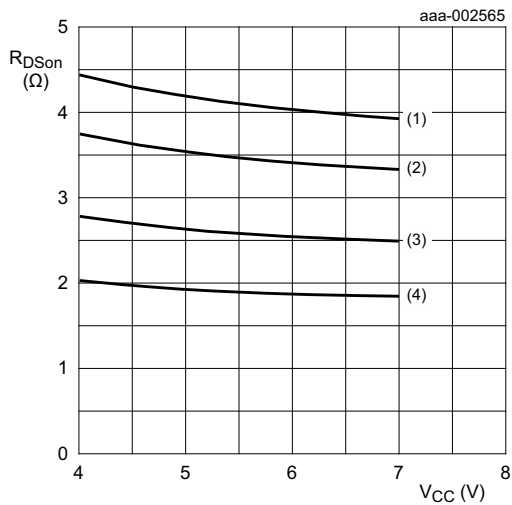
Fig 16. Supply current versus frequency



$V_I = V_{CC}$ or GND and $V_O = \text{GND or } V_{CC}$.

- (1) $T_{amb} = 125\text{ }^{\circ}\text{C}$
- (2) $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (3) $T_{amb} = 25\text{ }^{\circ}\text{C}$
- (4) $T_{amb} = -40\text{ }^{\circ}\text{C}$

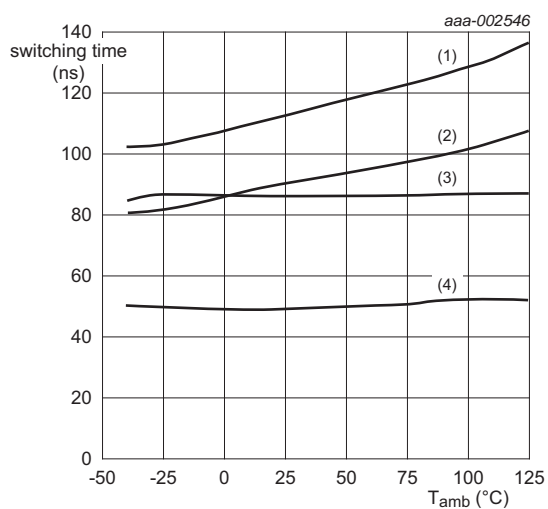
Fig 17. Drain-source on-state resistance versus drain current



$V_I = V_{CC}$ or GND and $V_O = \text{open circuit}$.

- (1) $T_{amb} = 125\text{ }^{\circ}\text{C}$
- (2) $T_{amb} = 85\text{ }^{\circ}\text{C}$
- (3) $T_{amb} = 25\text{ }^{\circ}\text{C}$
- (4) $T_{amb} = -40\text{ }^{\circ}\text{C}$

Fig 18. Static drain-source on-state resistance versus supply voltage



Technique should limit $T_J - T_C$ to 10 °C maximum.

- (1) t_{PLH} .
- (2) t_r .
- (3) t_f .
- (4) t_{PHL} .

Fig 19. Switching time versus case temperature

11. Package outline

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1

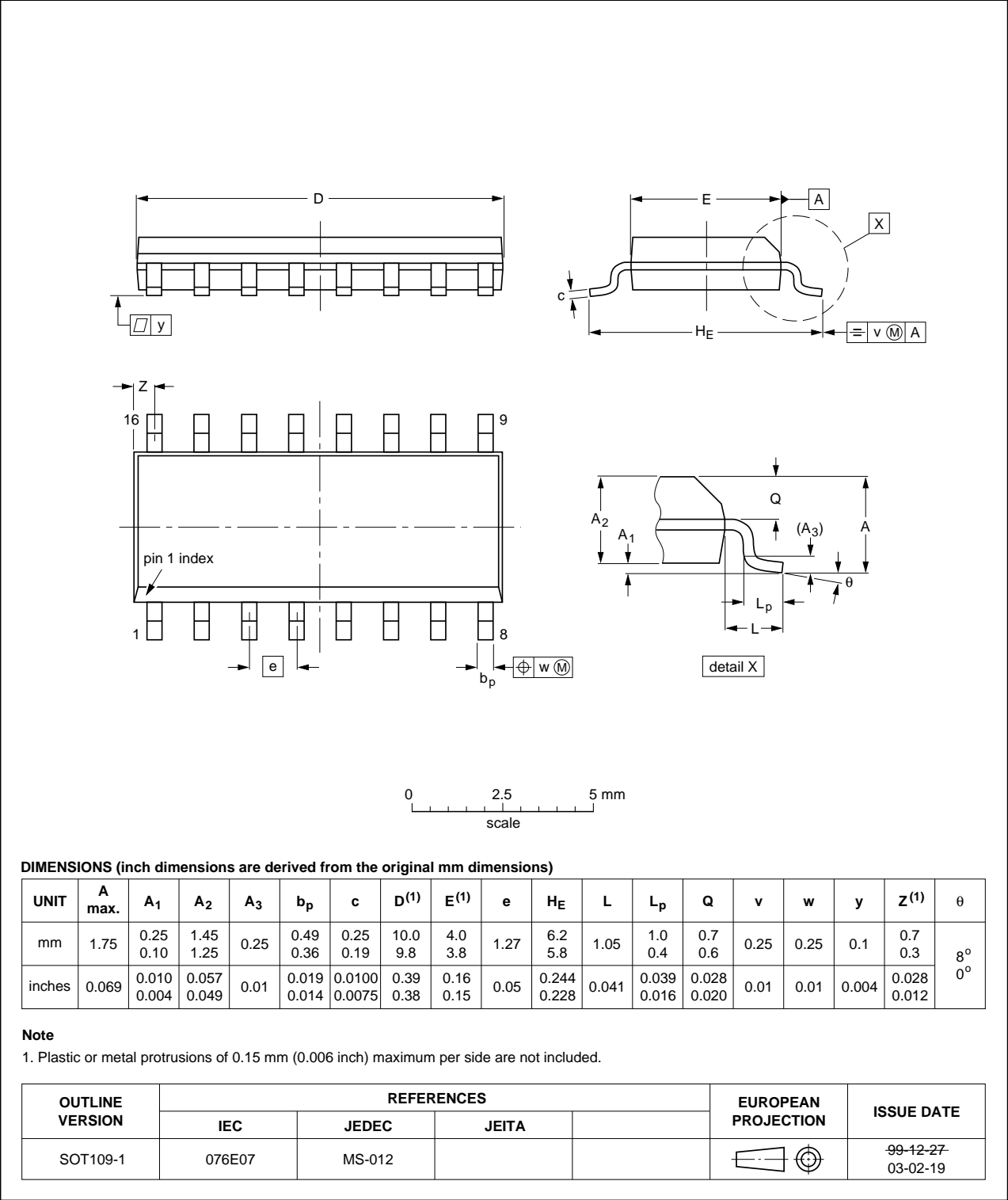


Fig 20. Package outline SOT109-1 (SO16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1

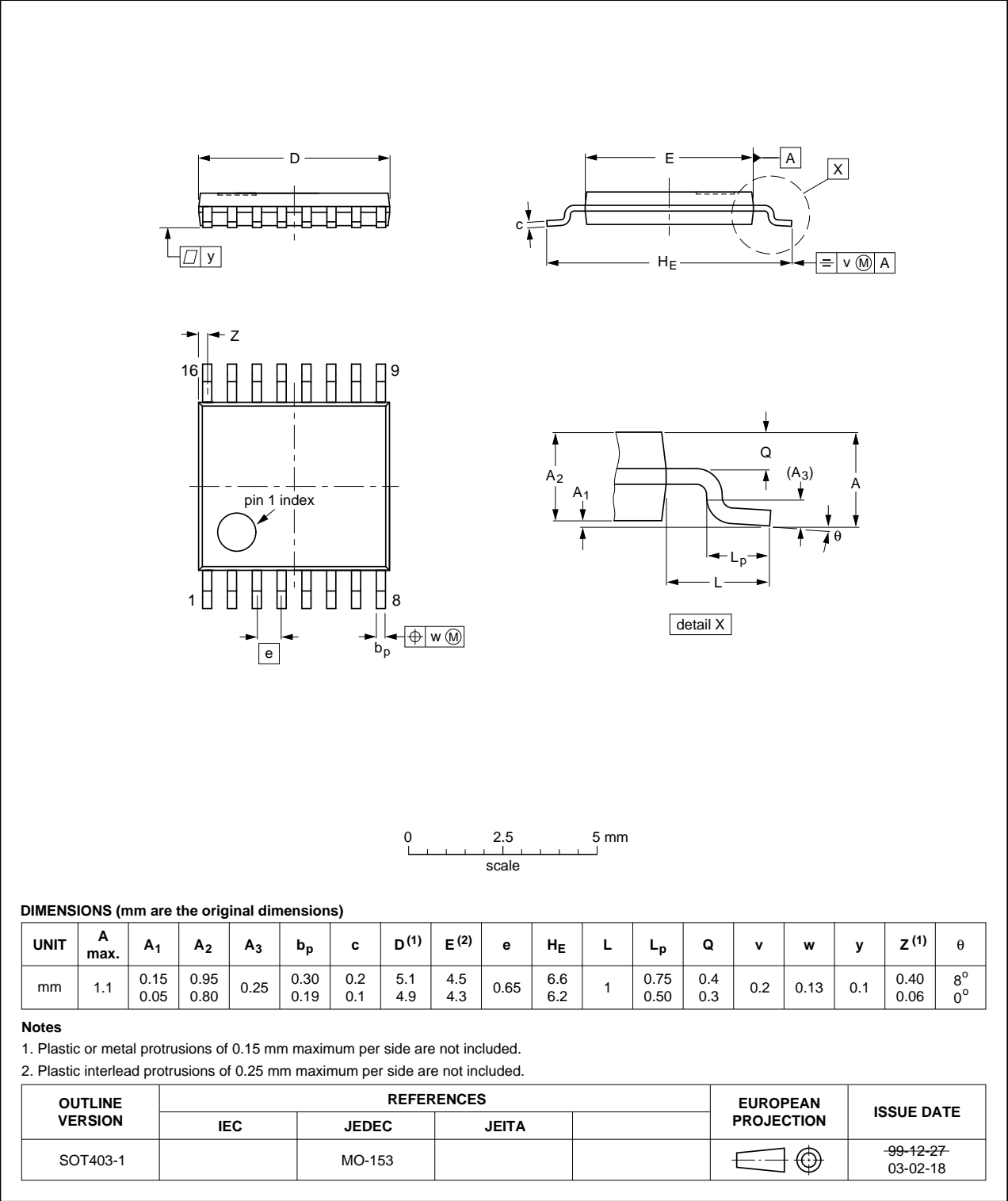


Fig 21. Package outline SOT403-1 (TSSOP16)

DHVQFN16: plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 16 terminals; body 2.5 x 3.5 x 0.85 mm SOT763-1

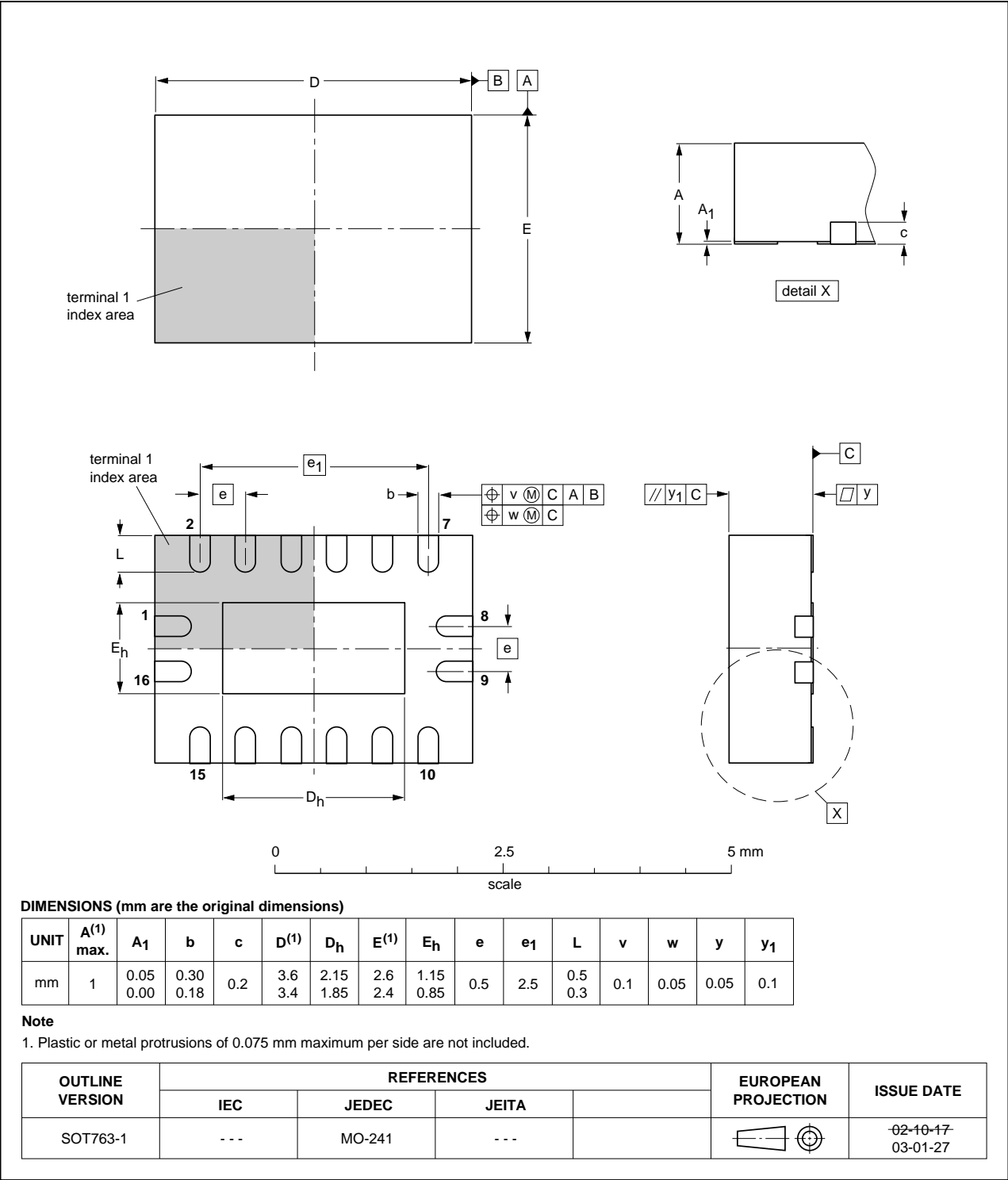


Fig 22. Package outline SOT763-1 (DHVQFN16)

12. Abbreviations

Table 10. Abbreviations

| Acronym | Description |
|---------|---|
| CDM | Charged Device Model |
| CMOS | Complementary Metal Oxide Semiconductor |
| DUT | Device Under Test |
| EDNMOS | Extended Drain Negative Metal Oxide Semiconductor |
| ESD | ElectroStatic Discharge |
| HBM | Human Body Model |
| TTL | Transistor-Transistor Logic |

13. Revision history

Table 11. Revision history

| Document ID | Release date | Data sheet status | Change notice | Supersedes |
|---------------------|--------------|--------------------|---------------|------------|
| NPIC6C596A_Q100 v.1 | 20131018 | Product data sheet | - | - |

14. Legal information

14.1 Data sheet status

| Document status ^{[1][2]} | Product status ^[3] | Definition |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet | Qualification | This document contains data from the preliminary specification. |
| Product [short] data sheet | Production | This document contains the product specification. |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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